



**Preliminary**

# **64Mb PPI MRAM M-die**

**Parallel Peripheral Interface MRAM**

**3.3V/1.8V**

- **S3R6416V1M**
- **S3R6416R1M**

## **Datasheet**

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## Feature

- Interface
  - Parallel Asynchronous and Page Mode Interface
- Page Mode Read Access
  - Interpage read access : 70ns
  - Intrapage read access : 15ns
- Page Mode Write Access
  - Interpage write access : 320ns
  - Intrapage write access : 15ns
- Page Size
  - x16 I/O Mode : 8-word page size
- Low Power Consumption
  - Read current(3.3V) : 27mA
  - Write current(3.3V) : 32mA
  - Read current(1.8V) : 20mA
  - Write current(1.8V) : 29mA
  - Standby current(3.3V) : 1.4mA
  - Standby current(1.8V) : 1.1mA
- Memory cell : STT-MRAM
  - nonvolatile
- Density
  - 64Mb
- Data Integrity : No external ECC required
- Data Endurance
  - Unlimited read cycle
  - $10^{14}$  write cycles
- Data Retention
  - 10 years at 85°C
- Single Power Supply Operation
  - S3R6416V1M: 2.70V~3.60V
  - S3R6416R1M: 1.71V~1.98V
- Operating Temperature Range
  - Industrial Temperature : -40°C to 85°C
- RoHS compliant packages
  - 48FBGA (6 mm x 8 mm)

## Performance

| Operation                  | Symbol     | Typical Values       |                      | Units |
|----------------------------|------------|----------------------|----------------------|-------|
|                            |            | 1.8V<br>(S3R6416R1M) | 3.3V<br>(S3R6416V1M) |       |
| Interpage Read Cycle Time  | $t_{RC}$   | 70(Min.)             |                      | ns    |
| Intrapage Read Cycle Time  | $t_{PRC}$  | 15(Min.)             |                      | ns    |
| Interpage Write Cycle Time | $t_{WC}$   | 320(Min.)            |                      | ns    |
| Intrapage Write Cycle Time | $t_{PWC}$  | 15(Min.)             |                      | ns    |
| Standby Current            | $I_{SB}$   | 1.1                  | 1.4                  | mA    |
| Interpage Read Current     | $I_{CCR}$  | 20                   | 27                   | mA    |
| Intrapage Read Current     | $I_{CCRP}$ | 20                   | 27                   | mA    |
| Interpage Write Current    | $I_{CCW}$  | 29                   | 32                   | mA    |
| Intrapage Write Current    | $I_{CCWP}$ | 29                   | 32                   | mA    |

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## General Description

The device is a Spin-Transfer-Torque Magneto-resistive Random Access Memory (STT-MRAM). Data is always non-volatile and the device can replace FRAM, low-power SRAM or nvSRAM with same functionality and help to simplify system design. Due to the non-volatility and virtually unlimited endurance characteristics of STT-MRAM, it is suited for code storage, data logging, backup memory and working memory in industrial designs.

It is a fully random-access memory with parallel asynchronous interface.  
It supports the asynchronous page mode function to enhance the read and write performance. The page size is 8 words.

The S3R6416(V/R)1M is packaged in industrial standard 48FBGA. These package is compatible with similar low-power volatile and non-volatile products.

The device is offered with industrial (-40°C to 85°C) operating temperature range.

## Pin Description – 3.3V Device

Figure 1 : Functional Block Diagram – 3.3V Device

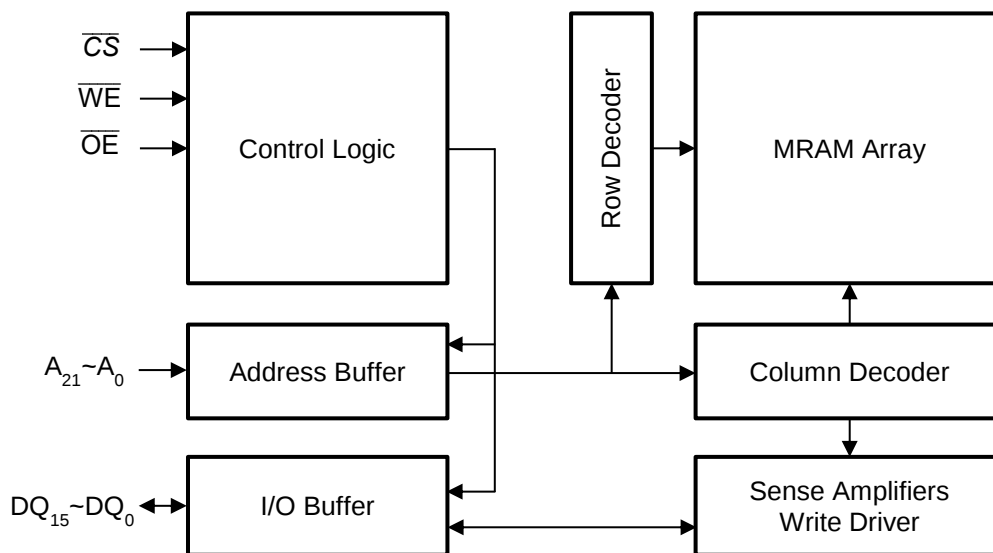


Table 1 : Pin Description – 3.3V Device

| Pin                 | Type          | Description                                                                                                                                                                                                                                                                                                                                                                   |
|---------------------|---------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| $\overline{CS}$     | Input         | <b>Chip Select:</b> When $\overline{CS}$ is driven Low, read or write operation are initiated. When $\overline{CS}$ is driven High, the device enters standby mode, and all other input pins are ignored and the output pins are tri-stated. $\overline{CS}$ should be High at power-up to prevent abnormal write operation. This pin does not have internal pullup resistor. |
| $\overline{WE}$     | Input         | <b>Write Enable:</b> When $\overline{CS}$ and $\overline{WE}$ are driven Low, write operation is initiated. The rising edge of $\overline{CS}$ causes the device to transfer the data to memory array. The rising edge of $\overline{WE}$ latches the input data. And, the falling edge of $\overline{WE}$ latches a new page address for write cycles.                       |
| $\overline{OE}$     | Input         | <b>Output Enable</b>                                                                                                                                                                                                                                                                                                                                                          |
| $A_{21} \sim A_0$   | Input         | <b>Address</b><br>The LSB address $A_2 \sim A_0$ are used for page mode read and write operation.                                                                                                                                                                                                                                                                             |
| $DQ_{15} \sim DQ_0$ | Bidirectional | <b>Data Input/Outputs</b>                                                                                                                                                                                                                                                                                                                                                     |
| Vcc                 | Supply        | Power pin                                                                                                                                                                                                                                                                                                                                                                     |
| Vss                 | Supply        | Ground pin                                                                                                                                                                                                                                                                                                                                                                    |
| NC                  | -             | Not Connected                                                                                                                                                                                                                                                                                                                                                                 |
| DNU                 | -             | Do Not Use : DNU's must be left unconnected.                                                                                                                                                                                                                                                                                                                                  |

## Pin Description – 1.8V Device

Figure 2 : Functional Block Diagram – 1.8V Device

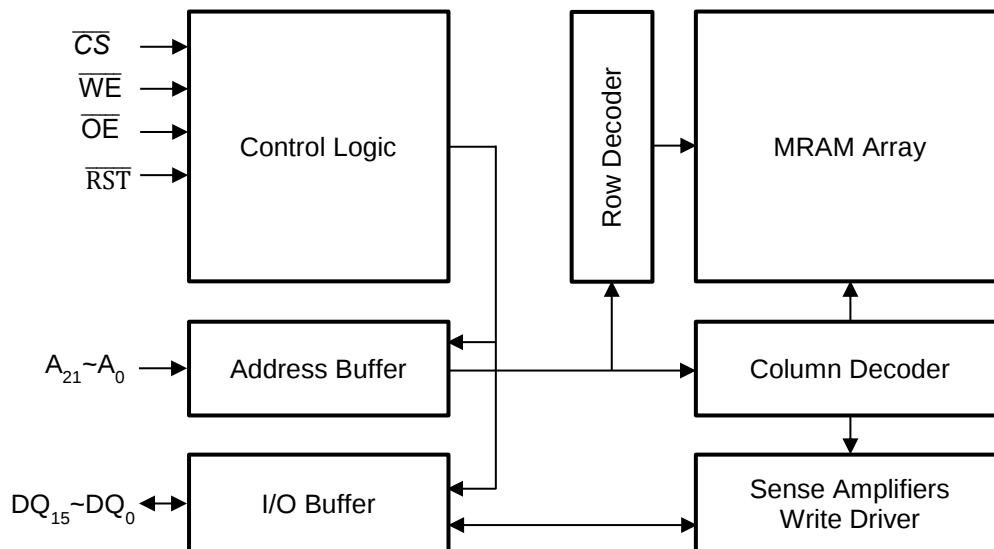
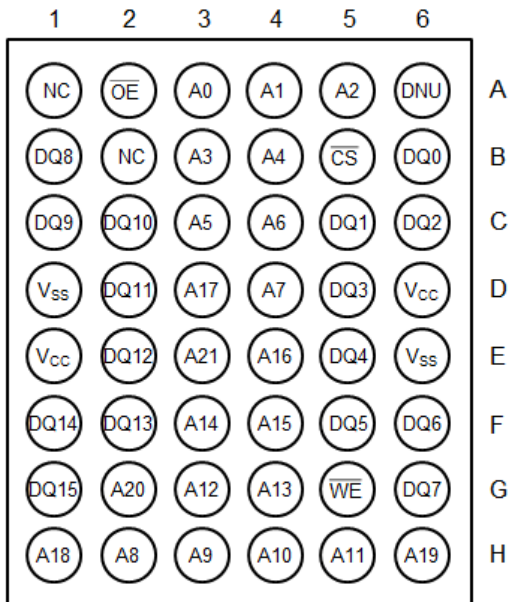


Table 2 : Pin Description – 1.8V Device

| Pin                 | Type          | Description                                                                                                                                                                                                                                                                                                                                                                   |
|---------------------|---------------|-------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| $\overline{CS}$     | Input         | <b>Chip Select:</b> When $\overline{CS}$ is driven Low, read or write operation are initiated. When $\overline{CS}$ is driven High, the device enters standby mode, and all other input pins are ignored and the output pins are tri-stated. $\overline{CS}$ should be High at power-up to prevent abnormal write operation. This pin does not have internal pullup resistor. |
| $\overline{WE}$     | Input         | <b>Write Enable:</b> When $\overline{CS}$ and $\overline{WE}$ are driven Low, write operation is initiated. The rising edge of $\overline{CS}$ causes the device to transfer the data to memory array. The rising edge of $\overline{WE}$ latches the input data. And, the falling edge of $\overline{WE}$ latches a new page address for write cycles.                       |
| $\overline{OE}$     | Input         | <b>Output Enable</b>                                                                                                                                                                                                                                                                                                                                                          |
| $A_{21} \sim A_0$   | Input         | <b>Address</b><br>The LSB address $A_2 \sim A_0$ are used for page mode read and write operation.                                                                                                                                                                                                                                                                             |
| $DQ_{15} \sim DQ_0$ | Bidirectional | <b>Data Input/Outputs</b>                                                                                                                                                                                                                                                                                                                                                     |
| $\overline{RST}$    | Input         | <b>Reset</b><br>$\overline{RST}$ pin is a hardware RESET signal. When $\overline{RST}$ is driven High, the device is in the normal operation mode. When $\overline{RST}$ is driven Low, the device enters in the initialization mode. This pin has an internal pullup resistor.                                                                                               |
| Vcc                 | Supply        | Power pin                                                                                                                                                                                                                                                                                                                                                                     |
| Vss                 | Supply        | Ground pin                                                                                                                                                                                                                                                                                                                                                                    |
| NC                  | -             | Not Connected                                                                                                                                                                                                                                                                                                                                                                 |
| DNU                 | -             | Do Not Use : DNUs must be left unconnected.                                                                                                                                                                                                                                                                                                                                   |

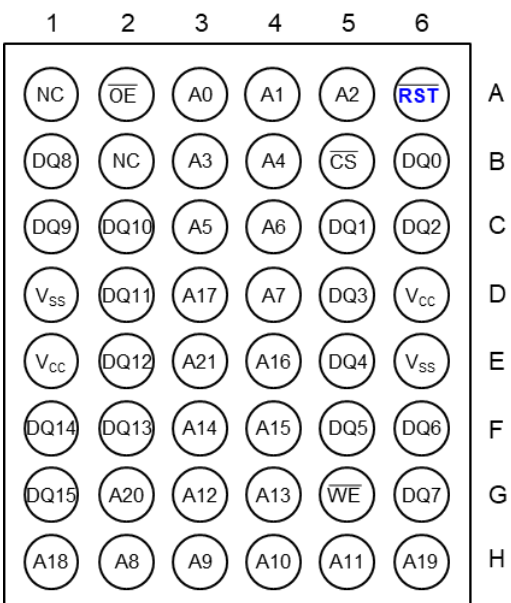
## Package Pin Configuration – 3.3V Device

48 Ball FBGA (x16)



## Package Pin Configuration – 1.8V Device

48 Ball FBGA (x16)



## Functional Description

### Functional Description – x16 I/O Mode

**Table 3 : Functional Description - x16 I/O mode**

| CS | WE | OE | DQ <sub>15</sub> ~DQ <sub>0</sub> | Modes          | Supply Current   |
|----|----|----|-----------------------------------|----------------|------------------|
| H  | X  | X  | High-Z                            | Not Selected   | I <sub>SB</sub>  |
| L  | H  | H  | High-Z                            | Output disable | I <sub>CCR</sub> |
| L  | H  | L  | Dout                              | Word Read      | I <sub>CCR</sub> |
| L  | L  | X  | Din                               | Word Write     | I <sub>CCW</sub> |

### Address Pin

**Table 4 : Address Pin**

| Density | Address Pin                     | Page Address Pin               |
|---------|---------------------------------|--------------------------------|
| 64Mb    | A <sub>21</sub> ~A <sub>0</sub> | A <sub>2</sub> ~A <sub>0</sub> |

## Electrical Specifications

### Absolute Maximum Ratings

Stresses greater than those listed may cause permanent damage to the device. This is a stress rating only. Exposure to maximum rating for extended periods may adversely affect reliability.

**Table 5 : Absolute Maximum Ratings**

| Parameter                                          | Min.                                                                                                                              | Max. | Units |
|----------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------|------|-------|
| Voltage on Vcc Supply Relative to VSS: 3.3V Device | -0.5                                                                                                                              | 3.8  | V     |
| Voltage on Any Pin relative to VSS : 3.3V Device   | -0.5                                                                                                                              | 3.8  | V     |
| Voltage on Vcc Supply Relative to VSS: 1.8V Device | -0.5                                                                                                                              | 2.35 | V     |
| Voltage on Any Pin relative to VSS : 1.8V Device   | -0.5                                                                                                                              | 2.35 | V     |
| Storage Temperature                                | -55                                                                                                                               | 150  | °C    |
| Operating Ambient Temperature                      | -40                                                                                                                               | 85   | °C    |
| ESD HBM (Human Body Model)                         | ≥  2000 V                                                                                                                         |      | V     |
| ESD CDM (Charged Device Model)                     | ≥  500 V                                                                                                                          |      | V     |
| Solder Reflow Process                              | JEDEC J-STD-020 reflow profiles<br>- Peak temperature ≤ 260°C<br>- The time above 255°C ≤ 30 seconds<br>- Reflow cycles ≤ 3 times |      |       |

### Endurance, Retention and Magnetic Immunity

**Table 6 : Endurance, Retention and Magnetic Immunity**

| Parameter                           | Conditions | Min.             | Max.   | Units       |
|-------------------------------------|------------|------------------|--------|-------------|
| Write Endurance                     | -25°C      | 10 <sup>14</sup> | -      | Cycles/page |
| Data Retention                      | 85°C       | 10               | -      | years       |
| Magnetic Field During Write or Read | -          | -                | 24,000 | A/m         |

### Recommended Operating Conditions

**Table 7 : Recommended Operating Conditions**

| Parameter / Condition            | Min. | Typ. | Max. | Units |
|----------------------------------|------|------|------|-------|
| Operating Temperature            | -40  | 25   | 85   | °C    |
| Vcc Supply Voltage : 3.3V Device | 2.7  | 3.3  | 3.6  | V     |
| Vcc Supply Voltage : 1.8V Device | 1.71 | 1.8  | 1.98 | V     |
| Vss Supply Voltage               | 0.0  | 0.0  | 0.0  | V     |

## Pin Capacitance

**Table 8 : Pin Capacitance**

| Parameter                    | Conditions                            | Typ. | Max. | Units |
|------------------------------|---------------------------------------|------|------|-------|
| Input Pin Capacitance        | TEMP = 25°C; f = 1 MHz; $V_{IN} = 0V$ | -    | 8    | pF    |
| Input/Output Pin Capacitance | TEMP = 25°C; f = 1 MHz; $V_{IO} = 0V$ | -    | 10   | pF    |

\* Capacitance is sampled and not 100% tested

## AC Test Condition

**Table 9 : AC Test Conditions**

| Parameter                                  | Value       |
|--------------------------------------------|-------------|
| Input pulse levels                         | 0.0V to Vcc |
| Input rise and fall times                  | 1ns/1V      |
| Input and output measurement timing levels | Vcc/2       |
| Output Load                                | CL = 30pF   |

## DC Characteristics

**Table 10 : DC Characteristics : 3.3V Device**

| Parameters             |           | Symbol     | Test Conditions                                                                                              | Min                 | Typ | Max                 | Unit |
|------------------------|-----------|------------|--------------------------------------------------------------------------------------------------------------|---------------------|-----|---------------------|------|
| Input Leakage Current  |           | $I_{LI}$   | $V_{IN} = V_{SS}$ to $V_{CC}$                                                                                | -2                  | -   | +2                  | uA   |
| Output Leakage Current |           | $I_{LO}$   | $\overline{CS}=V_{IH}$ or $\overline{OE}=V_{IH}$ or $\overline{WE}=V_{IL}$<br>$V_{OUT} = V_{SS}$ to $V_{CC}$ | -2                  | -   | +2                  | uA   |
| Read Current           | Random    | $I_{CCR}$  | $V_{CC}$ (max), $I_{OUT}=0mA$                                                                                | -                   | 27  | 34                  | mA   |
|                        | Page mode | $I_{CCRP}$ | $V_{CC}$ (max), $I_{OUT}=0mA$                                                                                | -                   | 27  | 34                  | mA   |
| Write Current          | Random    | $I_{CCW}$  | $V_{CC}$ (max)                                                                                               | -                   | 32  | 40                  | mA   |
|                        | Page mode | $I_{CCWP}$ | $V_{CC}$ (max)                                                                                               | -                   | 32  | 40                  | mA   |
| Standby Current        |           | $I_{SB}$   | $V_{CC}$ (max), $\overline{CS} \geq V_{CC}-0.2V$                                                             | -                   | 1.4 | 1.9                 | mA   |
| Input High Voltage     |           | $V_{IH}$   | -                                                                                                            | $0.7 \times V_{CC}$ | -   | $V_{CC}+0.3$        | V    |
| Input Low Voltage      |           | $V_{IL}$   | -                                                                                                            | -0.3                | -   | $0.2 \times V_{CC}$ | V    |
| Output High Voltage    |           | $V_{OH}$   | $I_{OH}=-1mA$                                                                                                | 2.4                 | -   | -                   | V    |
| Output Low Voltage     |           | $V_{OL}$   | $I_{OL}=2mA$                                                                                                 | -                   | -   | 0.4                 | V    |

**Table 11 : DC Characteristics : 1.8V Device**

| Parameters             |           | Symbol     | Test Conditions                                                                                              | Min                 | Typ | Max                 | Unit |
|------------------------|-----------|------------|--------------------------------------------------------------------------------------------------------------|---------------------|-----|---------------------|------|
| Input Leakage Current  |           | $I_{LI}$   | $V_{IN} = V_{SS}$ to $V_{CC}$                                                                                | -2                  | -   | +2                  | uA   |
| Output Leakage Current |           | $I_{LO}$   | $\overline{CS}=V_{IH}$ or $\overline{OE}=V_{IH}$ or $\overline{WE}=V_{IL}$<br>$V_{OUT} = V_{SS}$ to $V_{CC}$ | -2                  | -   | +2                  | uA   |
| Read Current           | Random    | $I_{CCR}$  | $V_{CC}$ (max), $I_{OUT}=0mA$                                                                                | -                   | 20  | 26                  | mA   |
|                        | Page mode | $I_{CCRP}$ | $V_{CC}$ (max), $I_{OUT}=0mA$                                                                                | -                   | 20  | 26                  | mA   |
| Write Current          | Random    | $I_{CCW}$  | $V_{CC}$ (max)                                                                                               | -                   | 29  | 38                  | mA   |
|                        | Page mode | $I_{CCWP}$ | $V_{CC}$ (max)                                                                                               | -                   | 29  | 38                  | mA   |
| Standby Current        |           | $I_{SB}$   | $V_{CC}$ (max), $\overline{CS} \geq V_{CC}-0.2V$                                                             | -                   | 1.1 | 1.7                 | mA   |
| Input High Voltage     |           | $V_{IH}$   | -                                                                                                            | $0.7 \times V_{CC}$ | -   | $V_{CC}+0.3$        | V    |
| Input Low Voltage      |           | $V_{IL}$   | -                                                                                                            | -0.3                | -   | $0.3 \times V_{CC}$ | V    |
| Output High Voltage    |           | $V_{OH}$   | $I_{OH}=-1mA$                                                                                                | 1.4                 | -   | -                   | V    |
| Output Low Voltage     |           | $V_{OL}$   | $I_{OL}=2mA$                                                                                                 | -                   | -   | 0.4                 | V    |

## AC Timing Parameters

Table 12 : Read AC Timing Parameter

| Parameter                                                        | Symbol     | Min. | Max. | Units |
|------------------------------------------------------------------|------------|------|------|-------|
| Read Cycle Time (Interpage)                                      | $t_{RC}$   | 70   | -    | ns    |
| Page Read Cycle Time (Intrapage)                                 | $t_{PRC}$  | 15   | -    | ns    |
| $\overline{CS}$ Read Active Time                                 | $t_{RCA}$  | 65   | -    | ns    |
| $\overline{CS}$ Falling to Valid Output Time                     | $t_{CO}$   | -    | 65   | ns    |
| Address Access Time <sup>2)</sup>                                | $t_{AA}$   | -    | 80   | ns    |
| Page Address Access Time                                         | $t_{PAA}$  | -    | 15   | ns    |
| $\overline{CS}$ Rising to Output Hold Time                       | $t_{COH}$  | 3    | -    | ns    |
| Address change to Output Hold Time <sup>2)</sup>                 | $t_{OH}$   | 30   | -    | ns    |
| Page address change to Output Hold Time                          | $t_{POH}$  | 5    | -    | ns    |
| $\overline{OE}$ Falling to Valid Output Time                     | $t_{OE}$   | -    | 15   | ns    |
| $\overline{CS}$ Rising to High-Z Output Time                     | $t_{CHZ}$  | -    | 8    | ns    |
| $\overline{OE}$ Rising to High-Z Output Time                     | $t_{OHZ}$  | -    | 8    | ns    |
| Address Transition to $\overline{CS}$ falling Time <sup>2)</sup> | $t_{CAS}$  | 0    | -    | ns    |
| $\overline{CS}$ Rising to Address Transition Time <sup>2)</sup>  | $t_{CAH}$  | 0    | -    | ns    |
| $\overline{WE}$ Rising to $\overline{CS}$ Falling Time           | $t_{WES}$  | 0    | -    | ns    |
| $\overline{CS}$ Rising to $\overline{WE}$ Falling Time           | $t_{WEH}$  | 0    | -    | ns    |
| $\overline{CS}$ High Time for Read End                           | $t_{CSDR}$ | 5    | -    | ns    |
| Address Transition Interval Time                                 | $t_{AX}$   | -    | 5    | ns    |

### Notes:

- Those parameters are applied for x16 I/O mode only.
- Address except for page address

## AC Timing Parameters

**Table 13 : Write AC Timing Parameter**

| Parameters                                                               | Symbol     | Min | Max | Unit |
|--------------------------------------------------------------------------|------------|-----|-----|------|
| Write Cycle Time (Interpage)                                             | $t_{WC}$   | 320 | -   | ns   |
| $\overline{CS}$ Write Active Time <sup>3)</sup>                          | $t_{WCA}$  | 20  | -   | ns   |
| $\overline{CS}$ Falling to End of Write Time                             | $t_{CW}$   | 20  | -   | ns   |
| Page Write Cycle Time (Intrapage)                                        | $t_{PWC}$  | 15  | -   | ns   |
| $\overline{WE}$ Falling to End of Write (invalid output does not appear) | $t_{WP}$   | 10  | -   | ns   |
| $\overline{WE}$ Falling to End of Write (invalid output appears)         | $t_{WP1}$  | 20  | -   | ns   |
| $\overline{WE}$ Falling to Output High-Z Time                            | $t_{WHZ}$  | -   | 8   | ns   |
| Valid Input Data to End of Write Time                                    | $t_{DS}$   | 8   | -   | ns   |
| End of Write to Valid Input Data Time                                    | $t_{DH}$   | 0   | -   | ns   |
| Address Transition Time to $\overline{CS}$ falling <sup>2)</sup>         | $t_{CAS}$  | 0   | -   | ns   |
| $\overline{CS}$ Rising to Address Transition Time <sup>2)</sup>          | $t_{CAH}$  | 0   | -   | ns   |
| Page Address Transition to $\overline{WE}$ falling Time                  | $t_{PAS}$  | 0   | -   | ns   |
| $\overline{WE}$ falling to Page Address Transition Time                  | $t_{PAH}$  | 10  | -   | ns   |
| $\overline{WE}$ High Time for Page Write                                 | $t_{PWH}$  | 3   | -   | ns   |
| $\overline{CS}$ High Time for Write End <sup>3)</sup>                    | $t_{CSDW}$ | 250 | -   | ns   |

### Notes:

- Those parameters are applied for x16 I/O mode only.
- Address except for page address
- $t_{WCA} + t_{CSDW} \geq t_{WC}$

## Power On/Off Sequence : 3.3V Device

- When power-up, power-down or power-loss,  $\overline{CS}$  must follow  $V_{CC}$  to provide data protection.
- It is recommended that  $\overline{CS}$  must follow  $V_{CC}$  when  $V_{CC}$  is below  $V_{CC}(\text{minimum})$  and during  $t_{PU}$ .
- A 10K $\Omega$  pull-up resistor between  $V_{CC}$  and  $\overline{CS}$  pin is recommended.
- Normal operation must start after  $t_{PU}$ .

Figure 3 : Power-Up/Down Behavior

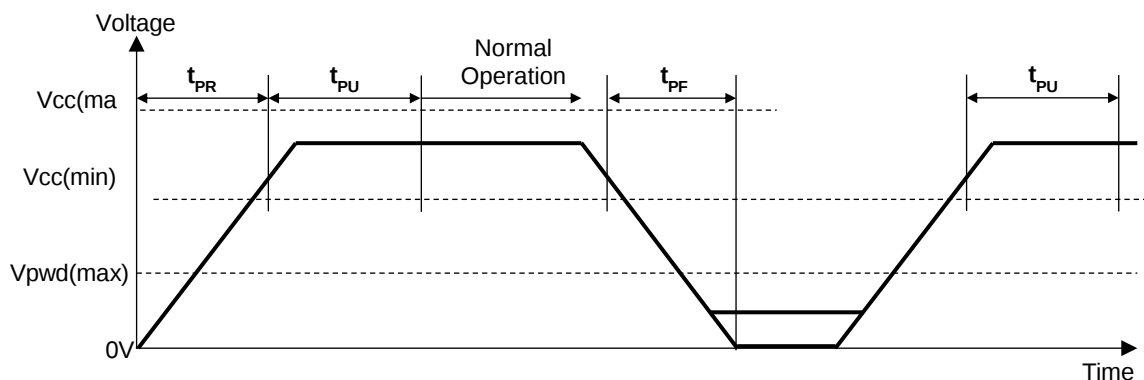


Table 14 : Power-Up/Down Timing

| Parameter                                                       | Symbol          | Min | Max | Units           |
|-----------------------------------------------------------------|-----------------|-----|-----|-----------------|
| Vcc Range                                                       | Vcc             | 2.7 | 3.6 | V               |
| Vcc rising time                                                 | $t_{PR}^{(1)}$  | 30  | -   | $\mu\text{s/V}$ |
| Vcc falling time                                                | $t_{PF}^{(1)}$  | 30  | -   | $\mu\text{s/V}$ |
| Vcc(min) to $\overline{CS}$ Low (first instruction) time        | $t_{PU}^{(1)}$  | 2.0 | -   | ms              |
| Vcc needed to below Vpwr for ensuring initialization will occur | $V_{PWR}^{(1)}$ | -   | 1.6 | V               |

### Notes:

1: These parameters are guaranteed by characterization; not tested in production.

## Power On/Off Sequence : 1.8V Device

- When power-up, power-down or power-loss,  $\overline{CS}$  must follow  $V_{CC}$  to provide data protection.
- It is recommended that  $\overline{CS}$  must follow  $V_{CC}$  when  $V_{CC}$  is below  $V_{CC}(\text{minimum})$  and during  $t_{PU}$ .
- A 10K $\Omega$  pull-up resistor between  $V_{CC}$  and  $\overline{CS}$  pin is recommended.
- Reset operation is required after  $t_{PU}$ .
- Normal operation must start after  $t_{RST}$ .

Figure 4 : Power-Up/Down Behavior

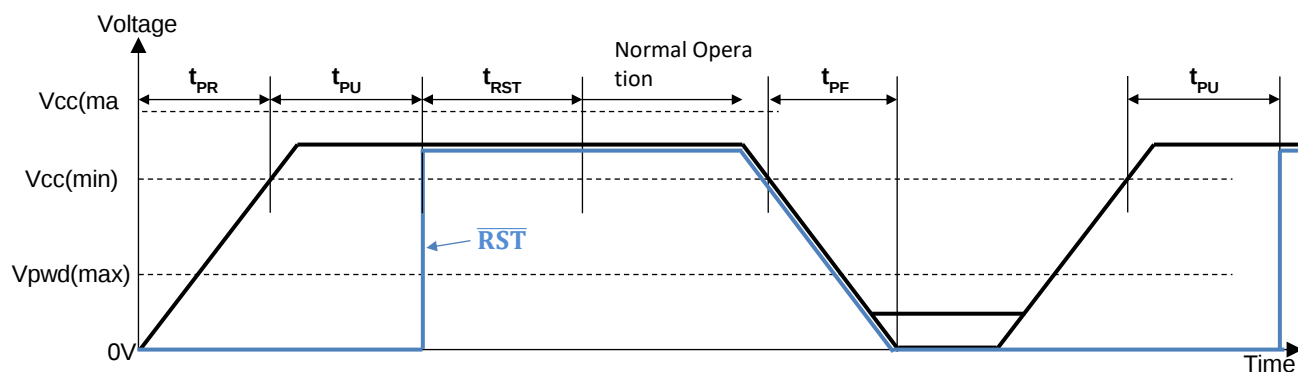


Table 15 : Power-Up/Down Timing

| Parameter                                                             | Symbol          | Min  | Max  | Units           |
|-----------------------------------------------------------------------|-----------------|------|------|-----------------|
| Vcc Range                                                             | Vcc             | 1.71 | 1.98 | V               |
| Vcc rising time                                                       | $t_{PR}^{(1)}$  | 30   | -    | $\mu\text{s/V}$ |
| Vcc falling time                                                      | $t_{PF}^{(1)}$  | 30   | -    | $\mu\text{s/V}$ |
| Vcc(min) to $\overline{RST}$ Low time                                 | $t_{PU}^{(1)}$  | 1.0  | -    | ms              |
| $\overline{RST}$ High to $\overline{CS}$ Low (first instruction) time | $t_{RST}^{(1)}$ | 2.0  | -    | ms              |
| Vcc needed to below Vpwd for ensuring initialization will occur       | $V_{PWD}^{(1)}$ | -    | 0.8  | V               |
| Reset Time                                                            | $t_{RST}^{(1)}$ | 2.0  | -    | ms              |

### Notes:

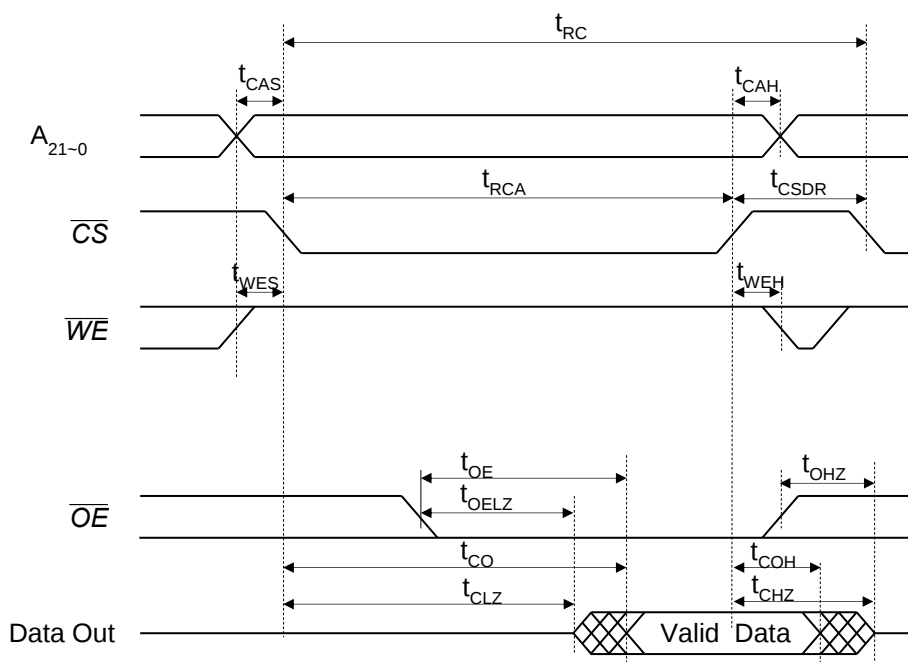
- 1: These parameters are guaranteed by characterization; not tested in production.

## Device Operation

### Read Operation : Interpage

Read operation is initiated when  $\overline{CS}$  goes to low and  $\overline{WE}$  is high. The falling edge of  $\overline{CS}$  latches the address and starts to read data from memory array. The output data are available after  $t_{CO}$ . The minimum random read cycle time is  $t_{RC}$ . The data remains in High-Z until the valid data is output.

Figure 5 : Timing Waveform of Read Cycle : x16 I/O mode



## Page Mode Read Operation : Intrapage

The device supports the page mode read function to enhance the read performance. It reads a page data from memory array and latches the data into an internal page buffer.

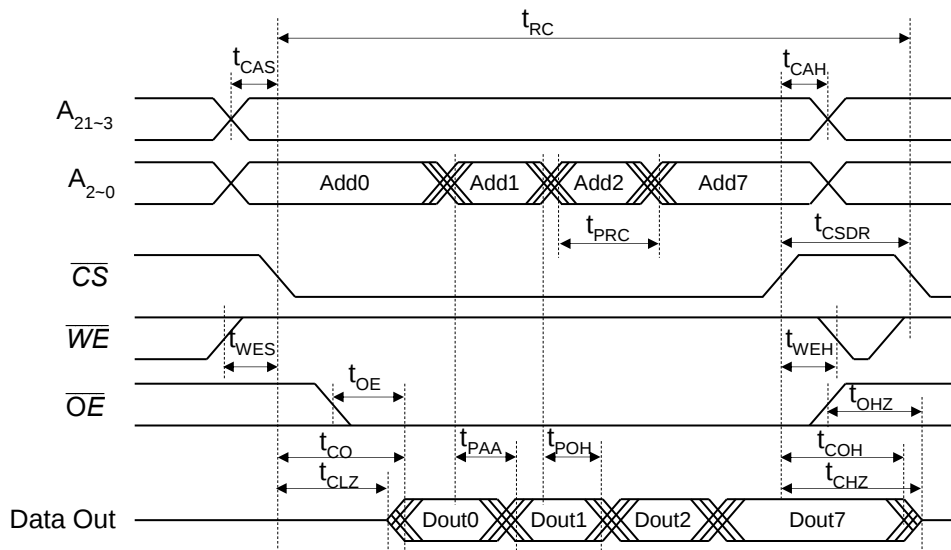
The first data is output after  $t_{CO}$ . When the next page address is input, subsequent data is output from the page buffer after  $t_{PAA}$ .

The sequence and length of page address are not restricted.

For example, the sequence A2-A0-A1 is available.

| Parameter    | x16 I/O mode      |
|--------------|-------------------|
| Page Address | $A_2 \sim A_0$    |
| Page size    | 8-word (16-bytes) |

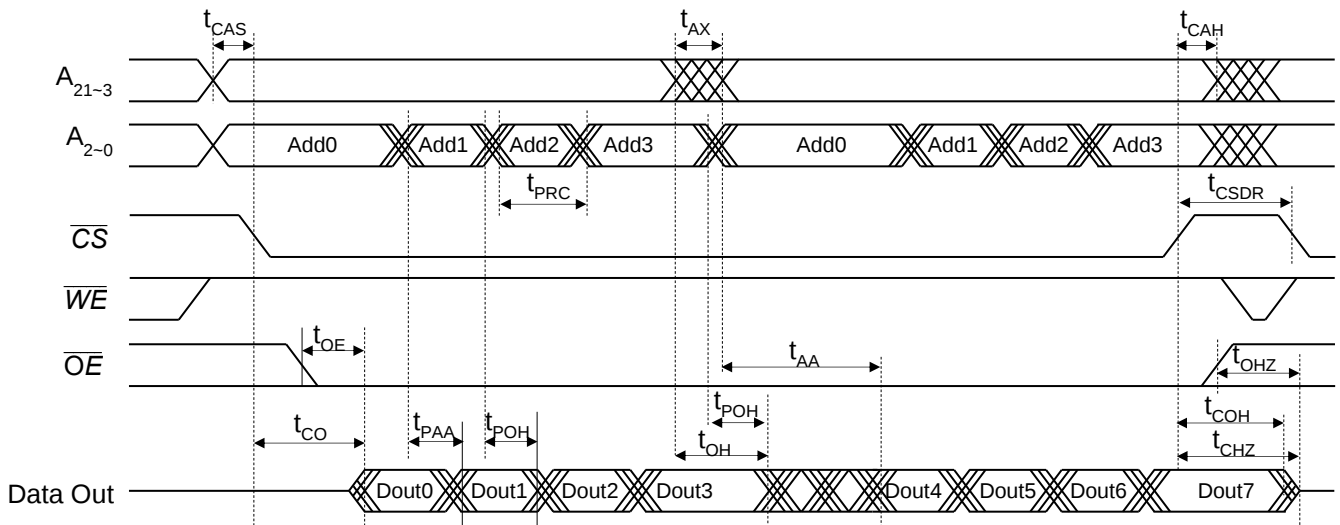
**Figure 6 : Timing Waveform of Page Mode Read Cycle : x16 I/O mode**



## Address Access Read Operation

During  $\overline{CS}$  is low and  $\overline{WE}$  is high, if a random address (except for the page address) are changed, the device reads a page data from memory array of a new address and latches the data into an internal page buffer. The first data is output after  $t_{AA}$ . When the next page address is input, subsequent data is output from the page buffer after  $t_{PAA}$ . The random address transition time should not exceed  $t_{AX}$ .

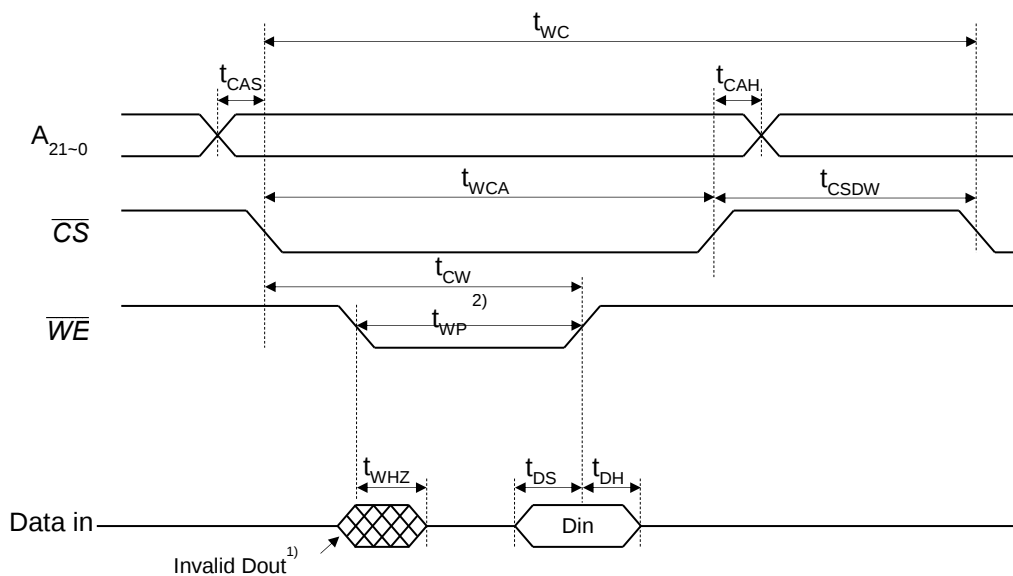
Figure 7 : Timing Waveform of Address Access Read Cycle : x16 I/O mode



## Write Operation ( $\overline{WE}$ control) : Interpage

Write operation is initiated when  $\overline{WE}$  goes to low and  $\overline{CS}$  is low. The device latches address on the falling edge of  $\overline{CS}$ . It latches the data on the rising edge of  $\overline{WE}$ . The rising edge of  $\overline{CS}$  causes the device to transfer the input data to memory array.

Figure 8 : Timing Waveform of Write Cycle ( $\overline{WE}$  control) : x16 I/O mode



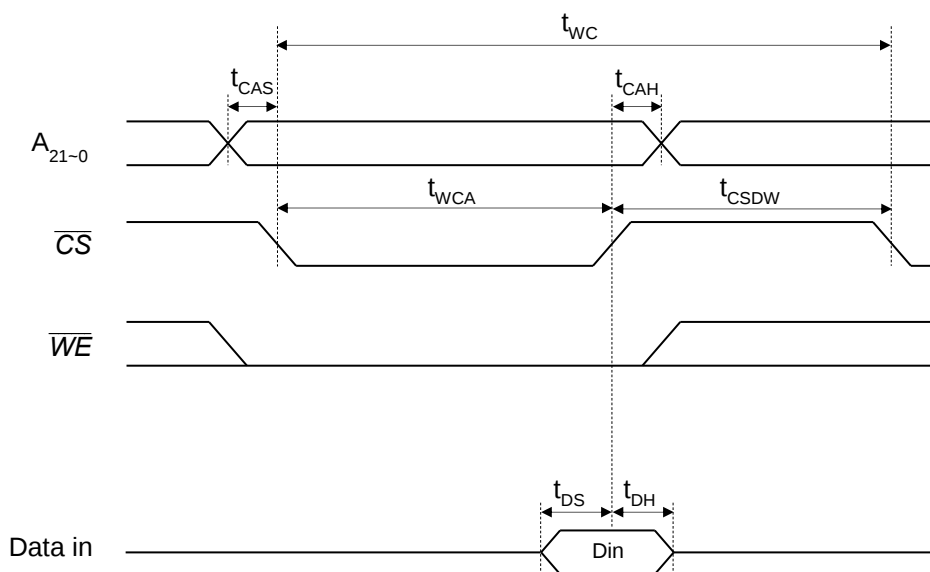
### Notes :

1. The data pins remain in High-Z state if the time of  $\overline{CS}$  falling to  $\overline{WE}$  falling is smaller than 30ns or  $\overline{OE}$  is High.
2. In case that the data pins do not remain in High-Z state,  $t_{WP}$  should be  $t_{WP1}$
3.  $t_{WCA} + t_{CSDW} \geq t_{WC}$

## Write Operation ( $\overline{CS}$ control) : Interpage

Write operation is initiated when  $\overline{CS}$  goes to low and  $\overline{WE}$  is low. The device latches address on the falling edge of  $\overline{CS}$ . It latches the data on the rising edge of  $\overline{CS}$ . The rising edge of  $\overline{CS}$  causes the device to transfer the input data to memory array.

Figure 9 : Timing Waveform of Write Cycle ( $\overline{CS}$  control) : x16 I/O mode



## Page Mode Write Operation : Intrapage

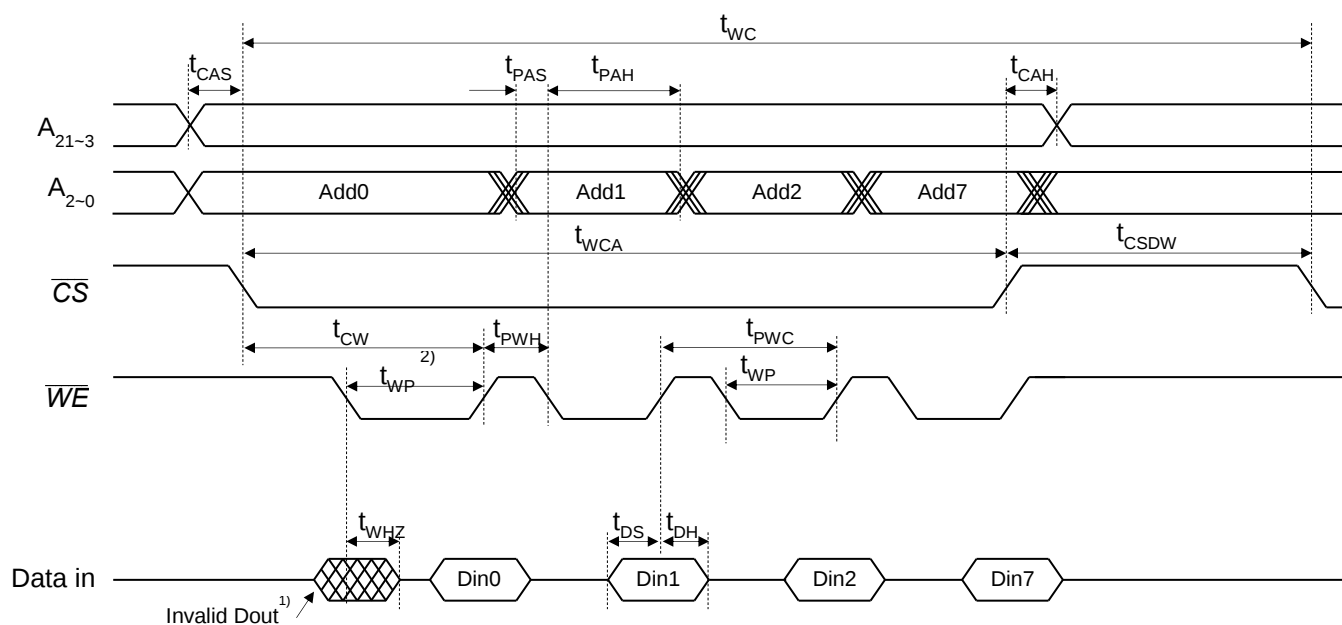
The device supports the page mode write function to enhance the write performance. It latches a page address every falling edge of  $\overline{WE}$ .

It latches the data on every rising edge of  $\overline{WE}$ . The rising edge of  $\overline{CS}$  causes the device to transfer the input data to memory array.

The sequence and length of page address are not restricted. For example, the sequence A2-A0-A1 is available.

| Parameter    | x16 I/O mode                   |
|--------------|--------------------------------|
| Page Address | A <sub>2</sub> ~A <sub>0</sub> |
| Page size    | 8-word (16-bytes)              |

Figure 10 : Timing Waveform of Page Mode Write Cycle : x16 I/O Mode



## Thermal Resistance

**Table 16 : Thermal Resistance**

| Parameter     | Description                              | 48FBGA | Unit |
|---------------|------------------------------------------|--------|------|
| $\theta_{JA}$ | Thermal resistance (junction to ambient) | 60.2   | °C/W |
| $\theta_{JC}$ | Thermal resistance (junction to case)    | 28.3   |      |

**Notes:**

1: These parameters are guaranteed by characterization; not tested in production

## Part Numbering System

| S | 3 | R | x | x | x | x | x | x | x  | -  | x  | x  | x  | x  | x  | x  | x  |
|---|---|---|---|---|---|---|---|---|----|----|----|----|----|----|----|----|----|
| 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 10 | 11 | 12 | 13 | 14 | 15 | 16 | 17 | 18 |

**Netsol  
Memory : S**

**MRAM : 3**

**Async Parallel  
Interface : R**

**Density**  
1Mb : 10, 2Mb : 20  
4Mb : 40, 8Mb : 80  
16Mb : 16, 32Mb : 32  
64Mb : 64

**I/O Organization**  
x8 : 08  
x16 : 16

**VCC**  
2.70~3.60V : V  
1.71~1.98V : R

**CS pin option**  
1CS pin : 1

**Special Code  
by customer request**  
Default : 00

**Packing Material**  
Tray : 0 T&R : T

**Speed**  
70ns : 70

**Temperature**  
Commercial : C  
Industrial : I

**Package**  
44TSOP2 : U  
54TSOP2 : P  
48FBGA : X

**Generation**  
1<sup>st</sup> Generation : M

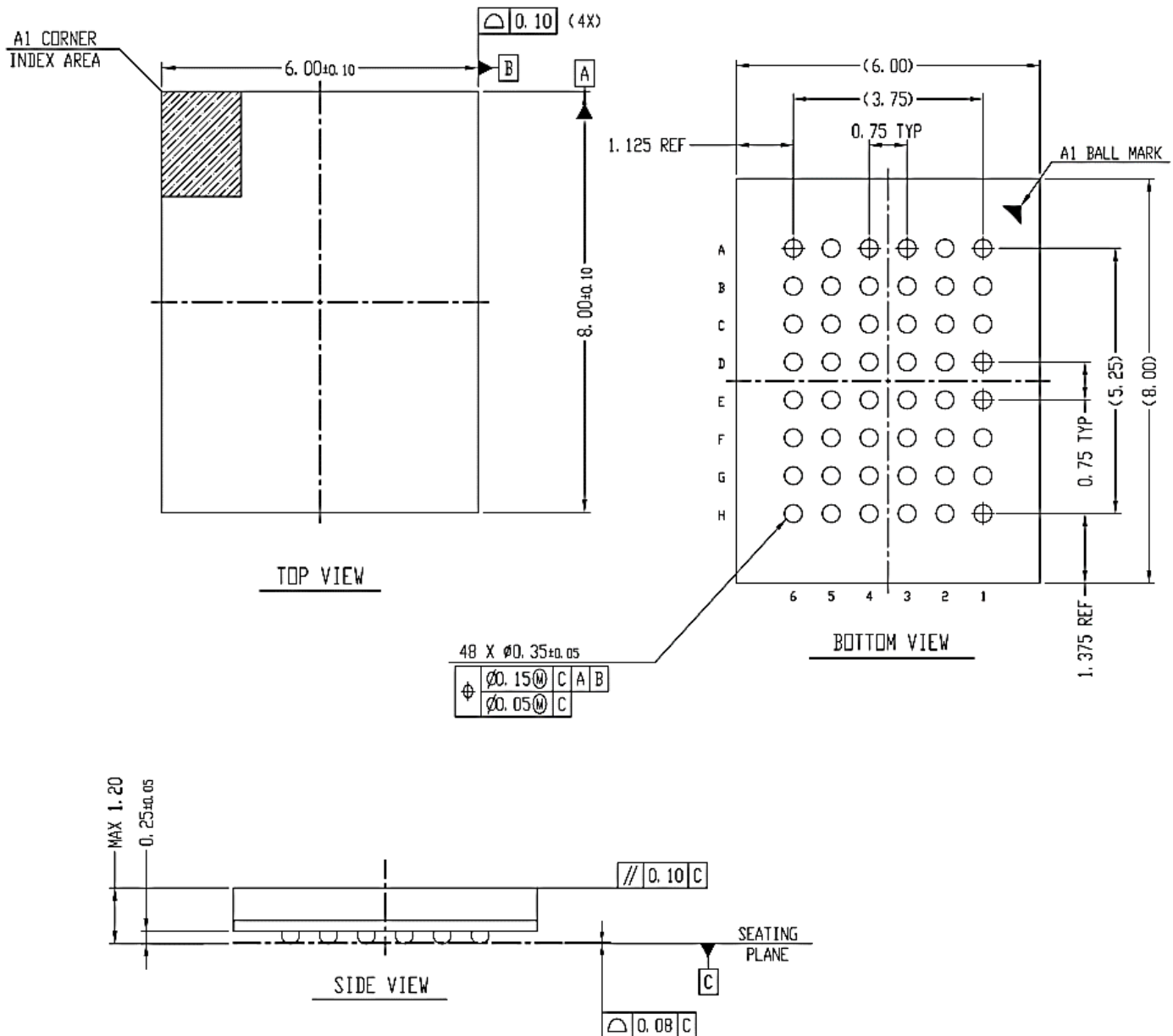
## Ordering Part Numbers

**Table 18 : Ordering Part Numbers**

| Density | Voltage | Temperature  | Package | Packing Material | Part Number      |
|---------|---------|--------------|---------|------------------|------------------|
| 64Mb    | 3.3V    | -40°C ~ 85°C | 48FBGA  | Tray             | S3R6416V1M-XI70  |
|         |         |              |         | Tape and Reel    | S3R6416V1M-XI70T |
|         | 1.8V    | -40°C ~ 85°C | 48FBGA  | Tray             | S3R6416R1M-XI70  |
|         |         |              |         | Tape and Reel    | S3R6416R1M-XI70T |

## Package Dimension

### 48 FBGA



#### [Notes]

1. All Dimensions in Millimeters
2. Solder ball Diameter is post reflow diameter  
(Raw Solder ball size is Ø0.30mm)

## Revision History

| Revision | Date      | Description                            |
|----------|-----------|----------------------------------------|
| 0.0      | Jun, 2023 | Initial Release, Preliminary           |
| 0.1      | Jul, 2023 | Update DC characteristics(Table 10,11) |
|          |           |                                        |
|          |           |                                        |